High-Definition X-Ray Fluorescence: Applications

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Energy dispersive X-ray fluorescence (EDXRF) is a well-established and powerful tool for nondestructive elemental analysis of virtually any material. It is widely used for environmental, industrial, pharmaceutical, forensic, and scientific research applications to measure the concentration of elemental constituents or contaminants. The fluorescing atoms can be excited by energetic electrons, ions, or photons. A particular EDXRF method, monochromatic microbeam X-ray fluorescence (μEDXRF), has proven to be remarkably powerful in measurement of trace element concentrations and distributions in a large variety of important medical, environmental, and industrial applications. When used with state-of-the-art doubly curved crystal (DCC) X-ray optics, this technique enables high-sensitivity, compact, low-power, safe, reliable, and rugged analyzers for in-situ, online measurements in industrial process, clinical, and field settings. This new optic-enabled μEDXRF technique is known as high-definition X-Ray fluorescence (HD XRF). Selected applications of HD XRF are described in this paper including air particulate analysis, analysis of body fluid contamination at ppb levels, elemental mapping of brain tissue and bone samples, as well as analysis of toxins in toys and other consumer products.

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1. Introduction

The need for sensitive, easy-to-use, accurate, portable, and nondestructive multielement analyzers for environmental, medical, industrial, and scientific uses has become increasingly important. Recent development of a high-definition X-Ray fluorescence (HD XRF) platform shows promise to meet this need. The principles and techniques for this HD XRF system are discussed in a companion paper [1]. In summary, state-of-the-art doubly curved crystal (DCC) x-ray optics enables high-sensitivity, compact, low-power, safe, reliable, and rugged analyzers for in-situ, online, measurements in industrial process, clinical, and field settings. A schematic diagram of an HD XRF system is shown in Figure 1. Selected applications of HD XRF are presented in this paper.

2. Trace Element Analysis

2.1. Environmental Particulate Analysis

Air quality has long been identified as a major public health issue and is the object of ongoing study and remediation efforts. Epidemiologic studies dating as early as the 1930s and extending through the 50s and 60s [2–4] indicate that human exposure to high concentrations of particulate matter (PM) results in serious health effects including higher death rates, particularly in children, elderly, and other physically vulnerable members of society. As a result, the Environmental Protection Agency (EPA) has regulated the levels of ambient PM since 1971. More recent studies indicate that even small, short-term increases in PM levels can induce significant increases in both mortality and morbidity from respiratory and cardiovascular diseases [5, 6]. Extensive air particulate monitoring (Federal Reference Method (FRM)) networks have been established with increased attention to finer particles (ambient particles are defined by their aerodynamic diameter: ultrafine, less than 1 μm; fine, 1–2.5 μm; and coarse, 2.5–10 μm, undifferentiated or total PM is sometimes collected which includes particles up to ~50 μm). Since 1978, the National Ambient Air Quality Standards (NAAQS) have regulated “inhalable” particles, sorted into particles with an aerodynamic diameter of 2.5 μm or less (PM2.5), 10 μm or less (PM10), or 2.5–10 μm (PM2.5–10). Medical and other effects tend to be studied in terms of these size designations,
with PM$_{2.5}$ (and more recently PM$_{1.0}$ or even PM$_{0.1}$) singled out for particular attention.

General air particulate monitoring in the (US), is concentrated principally in two networks: National Air Monitoring Stations (NAMS), and State and Local Air Monitoring Stations (SLAMS). These systems include over 5,000 monitors at approximately 3,000 sites. Recently, EPA has proposed combining these and other networks into the NCore Monitoring Network, a three-tier system of monitoring sites [7]. Of these, Level 2 would be a national network that would provide near real-time, high-quality PM$_{2.5}$ data plus routine chemical speciation.

The Center for Disease Control has published two of three projected National Reports on Human Exposure to Environmental Chemicals, the latest in 2005 [8]. Along with a large number of metabolites of organophosphate pesticides, cotinine, phthalates, aromatic hydrocarbons dioxins, herbicides, and so forth, a large number of metals such as Pb, Cd, Hg, Co, U, Sb, As, Ba, Be, Cs, Mo, Pt, Th, and W were included. The route of most of these toxins into the body is by ingestion and for some of them, the origin has been identified as principally geological, carried to humans or to the food chain through ground water. Others, however, have been associated with PM contamination. For example, Hg, which is a major health danger for children, is known to be introduced into the environment almost exclusively by combustion of coal. Although distribution and concentration in the food chain and subsequent ingestion is believed to be the most serious pathway to humans, the initial role of PM contamination as a primary source is important. PM involvement is also believed to be connected with Pb and Cd toxicity.

Little information is available on the direct and indirect involvement of PM on elemental (especially transition and heavy metal) toxicity. Therefore, direct, sensitive, and remote monitoring of trace metal PM contamination is of great importance.

In addition to possible toxic involvement, elemental speciation of PM in nearly real time can provide a sensitive signature on the sources of PM. Therefore, the shortest time resolution and widest possible distribution of trace element PM speciation monitors are important. The remarkable sensitivity, small size, low power, and low cost of HD XRF-based analysis has resulted in EPA and New York State Environmental Research Authority (NYSERDA) funding for development of a remote, near real-time HD XRF analyzer for PM speciation applications (EPA EP-D-06-089, NYSERDA Agreement no. 9392 PON944).

In addition to air particulate monitoring and analysis of general urban and remote air particulate exposure, there is intense current interest in determination of personal exposure to airborne particulate contamination. Two large government initiatives, the Genetics-Environment Initiative (GEI) [9], and the National Children’s Study (NCS) [10], have been recently announced by the Department of Health and Human Services. These initiatives include development of personal air particulate samplers with time- and even position-resolved measurement of the amount and composition of the personal exposure of targeted subjects. Miniaturization of air particulate collectors involves significantly reduced sampled air volumes and sample size both of which virtually preclude use of current laboratory-based elemental analysis techniques [11]. The high sensitivity of HD XRF is well suited for such analyses. Techniques and instruments for this purpose are being actively explored by X-Ray Optical Systems, Inc. (XOS) (East Greenbush, NY, USA) and Research Triangle Inc. (RTI) (Raleigh, NC, USA). An HD XRF spectrum for a small-area filter collected air particulate sample is shown in Figure 2. This spectrum illustrates the ability of HD XRF to measure many elements at the same time.
A tabulation of collected mass values for this sample from fundamental parameter (FP) analysis [1] is shown in Table 1. It is instructive to comment on some features of Figure 2 and Table 1 as follows. (1) The measured HD XRF intensities are plotted as the square root of the number of measured counts. This is convenient because it allows a large range of intensities to be shown on the same graph and it also makes it easy to estimate the statistical uncertainty from the Poisson statistics in the measurement. For example, the sqrt of the Fe Kα peak is ∼130 so the statistical uncertainty is 130/(130)² = 1/130 = 0.008 or 0.8%, and for the Ti Kα peak it is 1/20 = 5%. (2) The background measurement (shown in red), taken by shifting the sample so that the exciting beam is incident on a part of the filter displaced from the well-defined area on which the particles were collected, shows a low and nearly constant background. It also shows the Rayleigh (coherent) and Compton (incoherent) scattering of the incident monochromatic Mo Kα (17.6 keV) X-ray beam. The difference in the Rayleigh and Compton scattering between the observed particulate sample and the measured background filter sample is due to scattering from the observed (and unobserved) elemental constituents. This can be used to estimate the mass of low-mass elements in the sample [1]. (3) It is seen in Figure 2 that the Argon (Ar) peak is the same for the sample and background measurement. This peak is due to excitation of Ar in the volume of the air path in front of the sample that is exposed to both the exciting beam and the detector measurement cone. This does not change when the position of the filter is moved and provides a very convenient internal energy and intensity standard that shows that the geometry, incident beam intensity, and the detector response function were constant for the two measurements. (4) Finally, it is observed that three small peaks corresponding to Fe, Cu, and Pb are evident in the background spectrum. The Fe and Cu peaks are artifacts arising from small levels of contamination in the Aluminum collimating aperture in front of the detector and the Pb has been tentatively traced to contamination of the filter from handling and storage [11].

The same RTI collector used to collect the total particulate fraction in a small (2 mm) spot on the filter used for the measurement shown in Figure 2 also collected a more biologically important PM_{2.5} fraction in a larger spot on a different filter. The mass collected in this fraction is much smaller and the collection was over a larger area, ∼10 mm diameter. Measurement with a nearly normal incident beam as done for Figure 2 would require longer measurement time in order to obtain useful measurement statistics. The small analyzer incident beam spot leads to less efficient use of the exciting beam and lower measurement efficiency for large sample areas. However, changing the incident beam direction to a more glancing angle makes a significant difference. This is possible because of the small divergence of the incident beam. Figure 3 shows the spectrum and Table 2 shows the calculated masses for observed constituents for an incident angle of five degrees.

The important question is the following. How reliable are these results? To check this, measurements were made with an NIST air particulate standard SRM 2783. This standard was developed for standard particulate collection on 2.4 cm diameter filters. Measured and reference results are shown in Table 3. The measured and reference values are within the NIST-reported uncertainty in the reference and the statistical uncertainty in the measurement except for Ca and K for which the measured values are ∼26% and 43% lower than the reference values, respectively. The reasons for these discrepancies are not clear but may arise from a systematic error in the excitation probability adjustment (which is very large for such low Z elements for the Mo Kα excitation beam) or possibly from particle size effects, air absorption, or medium absorption (from penetration of the captured particles into the filter) due to the low XRF energy for these elements.

### Table 1: Mass per unit area of elements shown in Figure 2 from FP analysis [1]. Uncertainties shown are statistical Poisson statistics from peak intensities.

<table>
<thead>
<tr>
<th>Element</th>
<th>Pb</th>
<th>Fe</th>
<th>Zn</th>
<th>Ti</th>
<th>Ca</th>
<th>Cu</th>
<th>As</th>
<th>K</th>
</tr>
</thead>
<tbody>
<tr>
<td>Meas. Data (ng/cm²)</td>
<td>2080 ± 29.3</td>
<td>7578 ± 80.3</td>
<td>693 ± 7.2</td>
<td>763 ± 7.9</td>
<td>12096 ± 127</td>
<td>971 ± 9.8</td>
<td>139 ± 1.8</td>
<td>2080 ± 29.3</td>
</tr>
</tbody>
</table>

<table>
<thead>
<tr>
<th>Element</th>
<th>Cr</th>
<th>Mn</th>
<th>Ni</th>
<th>V</th>
<th>Rb</th>
<th>Sr</th>
<th>Br</th>
</tr>
</thead>
<tbody>
<tr>
<td>Meas. Data (ng/cm²)</td>
<td>42 ± 0.8</td>
<td>139 ± 1.8</td>
<td>55 ± 0.9</td>
<td>21 ± 0.7</td>
<td>7 ± 0.7</td>
<td>44 ± 1.4</td>
<td>35 ± 0.9</td>
</tr>
</tbody>
</table>

![Graph](image-url)
Conventional air particulate samplers use a sampling volume of 14.6 L/min onto filters typically 2.4 cm diameter. This has, in part, been motivated by direct-excitation XRF analysis that has a low flux per unit area and cannot concentrate the X-ray beam. The long measurement time was necessitated by the small spot size and the large collection area for the standard. Even so, the excellent S/B ratio allows statistically meaningful measurements and shows good agreement over a wide range of elements. Personal environmental monitors needed for large new national health initiatives such as the GEI [9] and NCS [10] will require lower collection volumes (perhaps 0.5-1 L/min), therefore, smaller pumps and lower power, and will involve much smaller filter or impact collector areas, in part to allow many collection positions on the same collecting substrate. New approaches for concentration of the aerosol flow stream are being explored in order to achieve desirable collector loading for shorter collection times. Because of its high sensitivity for measurement of low-sampling area, HD XRF may be an enabling analysis technology for particulate monitoring for biologically interesting PM2.5, other applications but will indicate the current status for some representative cases. As noted in the FP calculation discussion in [1], after thin samples, it is most straightforward to obtain quantitative results for homogeneous samples that are infinitely thick to the incident X-ray beam and/or the fluorescence X-rays. This includes many important applications such as measurements of trace elements in liquids such as water, fuel, and body fluids, and in homogeneous solid materials such as plastics or metals used in consumer products of interest for environmental and medical studies. For thick samples, additional factors such as incident X-ray and fluorescent X-ray absorption, X-ray scattering, and secondary excitation effects must be taken into account (1).

2.2. Trace Element Measurements in Bulk Materials

A much broader range of applications for HD XRF other than air particulate measurements includes trace and major constituent concentration measurements in natural, manufactured, and environmental materials for forensic, environmental, industrial, health, regulatory, and other applications. We will not attempt to review all current and potential applications but will indicate the current status for some representative cases. As noted in the FP calculation discussion in [1], after thin samples, it is most straightforward to obtain quantitative results for homogeneous samples that are infinitely thick to the incident X-ray beam and/or the fluorescence X-rays. This includes many important applications such as measurements of trace elements in liquids such as water, fuel, and body fluids, and in homogeneous solid materials such as plastics or metals used in consumer products of interest for environmental and medical studies. For thick samples, additional factors such as incident X-ray and fluorescent X-ray absorption, X-ray scattering, and secondary excitation effects must be taken into account (1).

2.2.1. Ultratrace Elements in Body Fluids

Measurements of the composition of body fluids (urine, blood, plasma) are among the most ubiquitous and powerful tools for disease detection and control. Simple physical

### Table 2: Mass per unit area of elements shown in Figure 3 from FP analysis [1]. Uncertainties shown are statistical Poisson statistics from peak intensities.

<table>
<thead>
<tr>
<th>Element</th>
<th>Pb</th>
<th>Fe</th>
<th>Zn</th>
<th>Ti</th>
<th>Ca</th>
<th>Cu</th>
<th>As</th>
<th>K</th>
</tr>
</thead>
<tbody>
<tr>
<td>Meas. Data (ng/cm²)</td>
<td>85.4 ± 1.2</td>
<td>237.1 ± 3.1</td>
<td>62.6 ± 1.0</td>
<td>25.6 ± 0.9</td>
<td>166.4 ± 2.7</td>
<td>11.4 ± 0.7</td>
<td>5.7 ± 0.9</td>
<td>204.3 ± 3.1</td>
</tr>
</tbody>
</table>

### Table 3: Reference data and measured data of air particulate on filter media from NIST (SRM 2783) with power of 50 kV 25 W, measurement time, 2 hours.

<table>
<thead>
<tr>
<th>As</th>
<th>Ca</th>
<th>Cr</th>
<th>Cu</th>
<th>Fe</th>
<th>K</th>
<th>Mn</th>
</tr>
</thead>
<tbody>
<tr>
<td>Ref. data (ng/cm²)</td>
<td>1.18 ± 0.12</td>
<td>1325.3 ± 170.7</td>
<td>13.6 ± 2.5</td>
<td>40.6 ± 4.2</td>
<td>2660.6 ± 160.6</td>
<td>530.1 ± 52.2</td>
</tr>
<tr>
<td>Meas. Data (ng/cm²)</td>
<td>1.25 ± 0.19</td>
<td>979.3 ± 105.5</td>
<td>11.9 ± 0.9</td>
<td>36.9 ± 1.0</td>
<td>2516.6 ± 26.2</td>
<td>302.2 ± 5.5</td>
</tr>
</tbody>
</table>

<table>
<thead>
<tr>
<th>Ni</th>
<th>Pb</th>
<th>Rb</th>
<th>Ti</th>
<th>V</th>
<th>Zn</th>
</tr>
</thead>
<tbody>
<tr>
<td>Ref. data (ng/cm²)</td>
<td>6.8 ± 1.2</td>
<td>31.8 ± 5.4</td>
<td>2.4 ± 0.6</td>
<td>149.6 ± 24.1</td>
<td>4.9 ± 0.6</td>
</tr>
<tr>
<td>Meas. Data (ng/cm²)</td>
<td>7.7 ± 0.3</td>
<td>33.8 ± 0.9</td>
<td>2.7 ± 0.2</td>
<td>130.7 ± 2.9</td>
<td>5.4 ± 0.2</td>
</tr>
</tbody>
</table>
measurements such as turbidity, sedimentation rate, color, and clarity, as well as sophisticated measurements of cholesterol, glucose, cell type, prostate-specific antigen (PSA), and so forth, are used to indicate current or potential disease or disorder. Self-testing is routinely used as a primary control guide for diseases such as diabetes. One class of measurement, less routinely applied but of increasing importance, is determination of trace element concentrations. Measurement of toxic metals, such as lead, cadmium, and arsenic, or radioactive isotopes is carried out when exposure to these materials is suspected. In addition, it is increasingly recognized that the appearance of even common metals in places where they should not be, such as iron in urine or manganese in blood, can indicate organ malfunction or pathogen-initiated disease. In some cases, absence or low levels of some elements such as zinc or selenium can signal danger. Often, the concentration level of trace elements of significance is in the range of 10–100 part-per-billion (ppb) and simple, fast measurement techniques at this level of sensitivity are not readily available.

In an NIH-supported study (NIH 2R44RR021797-02), development of an HD XRF-based analyzer for measurement of trace elements of importance for understanding and potential diagnosis and treatment of neurodegenerative diseases has recently begun at XOS in collaboration with the Alzheimer’s Center (Albany Medical Center, Albany, NY, USA) and the Wadsworth Center (New York State Department of Health, Albany, NY, USA). The object of this study is a clinically based analyzer for rapid, nondestructive analysis of trace element concentrations at ppb levels. Currently, only complex and expensive chemical analysis such as inductively coupled plasma mass spectrometry (ICP-MS) is capable of such measurements at the low ppb levels required [12]. This results in expense and delay (typically up to three weeks) such that desired analyses are often not carried out for diagnostic evaluation. Furthermore, the rapid results needed to monitor chelation therapy are impractical. The goal of this funded program is to permit inexpensive and accurate measurements of trace metals such as Fe, Cu, and Zn at the clinical point of care at concentration levels less than 10 ppb. Preliminary measurements have already shown good agreement with ICP-MS at levels as low as 40 ppb as shown in Figure 4 and Table 4. In addition to Alzheimer’s Disease and other neurodegenerative disorders that are the focus of the current study [13, 14], such measurements are important to a variety of metabolic disorders such as Wilson’s disease (a copper overload disease) [15], hemochromatosis (a family of Fe overload disorders) [16], and toxic effects of Pb [17], As [18], Hg [19], Cd [20], and Sb [21]. It is expected that such point-of-care analyzers will also be important for renal diseases and a variety of autoimmune diseases. It is interesting to note that for many of these cases, the elements of interest are not the traditional toxins but are often bioessential elements, which makes the broad elemental range of HD XRF particularly valuable.

Small peaks corresponding to Au, Cu, and Zn are observed in Figure 3. These are all due to detector-related artifacts. The Au is from secondary excitation of Au in the electrode on the front face of the detector and the Cu and Zn have been identified as secondary excitation of impurities in the Aluminum collimator in front of the detector. These measurements were taken with a preliminary prototype system. The NIH-funded project, which started in October 2007, is designed to improve the measurement sensitivity to allow minimum quantifiable limits for Pb, As, Zn, Cu, and Fe down to 5 ppb or less. This will include application of multiple optic excitation as well as detector resolution, counting rate, and artifact removal improvements. No other laboratory-based multielement XRF system can achieve such low detection limits.

The detection limits for Pb and As in urine was estimated based on the above preliminary data. The minimum detection concentration is given by

\[
\text{MDC} = \frac{3\sqrt{\text{Background}}}{\text{Signal}} W_i = \frac{3\sqrt{B}}{S\sqrt{T}} W_i = \frac{3\sqrt{B/T}}{\sqrt{S \times T}} W_i, \quad (1)
\]
where $B$ is the background count rate in cps, $S$ is the signal count rate in cps, $t$ is the measurement time in seconds, and $W_i$ is the reference sample weight concentration. For the sample EU03-5, the As net counting rate was measured to be 1.2 cps and the background counting rate was 25 cps. Therefore, the detection limits for 1600 seconds for As = $3 \times 5 \times 117/1.2 = 40$–36 ppb. Similarly, detection limits for Pb were found to be about 45 ppb for 1600-second measurements with this early prototype system based on the signal and background level of sample EU03-3.

### 2.2.2. Toxins in Toys and Other Consumer Products

There is a great deal of interest in control of toxic elements, particularly Lead, in toys, children’s play equipment, furniture, and all items that could contribute to exposure of children to harmful substances. In addition, the European Union has, under the EU directives: Restriction on the use of certain Hazardous Substances (RoHS) (2002/96/EG) and Waste Electrical and Electron Equipment (WEEE) (2002/95/EG), restricted the amount of a number of elements and compounds in electronic materials and electrical equipment provided to the European market as of June, 2006. These include, Pb, Hg, Cd, Cr$^{6+}$, and certain compounds of Br. In addition Ba, Sb, and Se have been identified as potentially harmful at high levels. These elements are also of concern for toys and children’s and household furniture, as well as other consumer products. Many of the items of interest are made of molded or painted plastic and often of painted wood.

#### 2.2.2.1. Homogeneous solids

Analysis of homogeneous plastic materials can be carried out by the same FP approach as that used for the liquid samples discussed in the previous subsection. Comparisons of such analyses for homogeneous polyethylene (PE) plastic standard samples are shown in Figure 5 and Table 5.

The analytical simulation fundamental parameter (SFP) analysis [1] used in this example is fast but not automated. It requires fitting of the peak intensity for both the Rayleigh and Compton scattering peaks (even though the shape of the Compton peak is not matched) and for the major peaks in the spectrum for each observed element. The simulation takes into account secondary excitation, peak overlap, and absorption effects even for unobserved elements (such as H, C, O, and N). An automated reverse fundamental parameter (RFP) analysis is more desirable and is possible for simple homogeneous samples as shown in what follows. This case is shown because the SFP analysis is still available for quantitative concentration determinations even while the more complex RFP algorithms are being developed (especially for multilayer samples).

Plastic toys and other plastic-consumer products are principally made from polyethylene (PE), polyethylene terephthalate (PET), or acrylonitrile butadiene styrene (ABS). These plastic matrices are very similar in their behavior to FP plastic doped ABS standards with markedly different Pb content, and Table 6 shows the results of automated RFP analysis for four NMIJ standards. The measurement time for each was 120 seconds and the analysis time was <10 seconds. As with Figure 5, it is observed that the Rayleigh and Compton scattering peaks are very strong for these low Z matrices. Another plastic used extensively for consumer products is polyvinyl chloride (PVC).

### Table 4: Measured As and Pb levels in five reference urine samples compared with the results of an interlaboratory study by ICP-MS measurements.

<table>
<thead>
<tr>
<th>Sample</th>
<th>HD XRF</th>
<th>ICP-MS</th>
<th>HD XRF</th>
<th>ICP-MS</th>
</tr>
</thead>
<tbody>
<tr>
<td>EU03-1</td>
<td>&lt;35</td>
<td>11.8 ± 2.1</td>
<td>80 ± 25</td>
<td>79.4 ± 4.4</td>
</tr>
<tr>
<td>EU03-2</td>
<td>&lt;35</td>
<td>3.2 ± 0.9</td>
<td>&lt;40</td>
<td>&lt;0.7</td>
</tr>
<tr>
<td>EU03-3</td>
<td>154 ± 15</td>
<td>158.9 ± 7.7</td>
<td>524 ± 25</td>
<td>528 ± 26</td>
</tr>
<tr>
<td>EU03-4</td>
<td>40 ± 12</td>
<td>56.8 ± 3.0</td>
<td>212 ± 20</td>
<td>224.8 ± 8.3</td>
</tr>
<tr>
<td>EU03-5</td>
<td>104 ± 18</td>
<td>114.8 ± 5.0</td>
<td>&lt;40</td>
<td>5.2 ± 1.5</td>
</tr>
</tbody>
</table>

**Figure 5:** HD XRF spectrum from polyethylene standard PE 5398 L sample and analytical simulated spectrum from fundamental parameter analysis. A background subtraction was made for the spectrum below 15.2 keV.
Table 5: Reference and measured values for three polyethylene standards. The experimental uncertainty (at 95% level) includes estimated systematic uncertainty plus Poisson counting statistical error.

<table>
<thead>
<tr>
<th>Sample</th>
<th>Cr</th>
<th>Hg</th>
<th>Pb</th>
<th>Br</th>
<th>Error</th>
</tr>
</thead>
<tbody>
<tr>
<td>PE5398_N</td>
<td>Reference</td>
<td>1001</td>
<td>1000</td>
<td>1000</td>
<td>500</td>
</tr>
<tr>
<td></td>
<td>Measured</td>
<td>1020</td>
<td>950</td>
<td>981</td>
<td>442</td>
</tr>
<tr>
<td>PEH18A</td>
<td>Reference</td>
<td>1000</td>
<td>1100</td>
<td>1200</td>
<td>1100</td>
</tr>
<tr>
<td></td>
<td>Measured</td>
<td>1020</td>
<td>1150</td>
<td>1220</td>
<td>1090</td>
</tr>
<tr>
<td>PEL</td>
<td>Reference</td>
<td>400</td>
<td>200</td>
<td>400</td>
<td>500</td>
</tr>
<tr>
<td></td>
<td>Measured</td>
<td>401</td>
<td>185</td>
<td>419</td>
<td>508</td>
</tr>
</tbody>
</table>

**Figure 6:** HD XRF spectra for ABS plastic standards.

Detailed discussion of the methods used to obtain concentrations shown in Tables 1–9 is given in the companion paper on HD XRF principles and techniques [1].

Even though the analysis software development is not yet completed for general matrices, it is possible for a variety of homogeneous plastic solid and homogeneous liquid samples to carry out an RFP analysis in a few seconds. The rapid analyses and the low level of detection are enabled by the use of monochromatic excitation and the high beam intensity in the HD XRF system. Analysis refinements that are underway are connected with spectrum preprocessing and background and peak overlap corrections. The minimum detection concentration calculated by (1) is shown for Cr, Hg, and Pb in Table 6. It can be seen that MDC values achievable by the prototype HD XRF system for toxins in homogeneous plastic products are in the low ppm range.

### 2.2.2.2. Layered Solids

Layered materials present a much more difficult problem, for which the analysis is at an even earlier stage of development. The special features of HD XRF of monochromatic excitation and small analysis spot size are particularly important for analysis of layered materials. It is instructive to consider a specific example that illustrates the power of HD XRF in measuring elemental concentration in layered samples. This example is a well-known promotional ceramic cup with the “I Love NY” slogan. A photograph of such a cup with HD XRF spectra for the white ceramic cup, the printed black lettering, and the printed red heart is shown in Figure 7. Superposition of the three spectra is shown in Figure 8 where the square root of the number of measured counts is used to emphasize some of the low-intensity features.

A number of features are worthy of note in the superposed spectra shown in Figure 8 and described as follows.

(i) The elastic (Rayleigh) and inelastic (Compton) scattering peaks are much lower, relative to other features than observed for plastic matrices in Figures 4 and 5. This is due to the lower concentrations of low Z elements (particularly hydrogen) in the ceramic cup and in the painted layers.

(ii) Pb, Co, Fe, Cr are present in the black lettering but are at lower levels or absent in the white cup.

(iii) Pb and Se are present in the red heart.

(iv) Ca, Sr, and Zn are principle constituents of the white cup, probably as part of the ceramic which also, of course, is expected to contain oxygen, carbon, and nitrogen and may contain other major constituents such as Si and Al which are not observed.

(v) Of special note is the observation of four characteristic lines from Pb (Pb M, Pb Lα, Pb Lβ, and Pb Lγ). The relative excitation probability for these lines can be looked up from tabulated excitation tables, and absorption coefficients are also available from tabulations using the material density derived in the iterative FP calculation. Therefore, their relative observed intensities (particularly the Pb M line) can be used in the FP analysis to determine the thickness of the black paint layer.

(vi) Similarly, attenuation of the Sr and Zn peaks can give information on the thickness of the black and red paint layers.

Taking these effects into account, by using the analytical simulation calculation, the concentration of elements in the white cup and in the black and red paint layers have been calculated and are shown in Tables 7, 8, and 9. The very high Pb concentration in the black lettering is of special interest.
Table 6: RFP analysis for ABS plastic standards.

<table>
<thead>
<tr>
<th>Sample</th>
<th>Cr (ppm)</th>
<th>Hg (ppm)</th>
<th>Pb (ppm)</th>
</tr>
</thead>
<tbody>
<tr>
<td></td>
<td>Reference</td>
<td>Measured</td>
<td>Reference</td>
</tr>
<tr>
<td>NMIJ CRM 8105a</td>
<td>27.5 ± 0.5</td>
<td>25.0 ± 3.2</td>
<td>N/A</td>
</tr>
<tr>
<td>NMIJ CRM 8106a</td>
<td>268.1 ± 2.1</td>
<td>276 ± 17</td>
<td>N/A</td>
</tr>
<tr>
<td>NMIJ CRM 8115a</td>
<td>94.3 ± 1.1</td>
<td>91.2 ± 9.0</td>
<td>93.8 ± 2.8</td>
</tr>
<tr>
<td>NMIJ CRM 8116a</td>
<td>944 ± 12</td>
<td>946 ± 32</td>
<td>939 ± 27</td>
</tr>
<tr>
<td>Minimum detection concentration (MDC)</td>
<td>7.4</td>
<td>1.4</td>
<td>1.4</td>
</tr>
</tbody>
</table>

Figure 7: Photograph of promotional “I Love NY” cup and HD XRF spectra for the white ceramic, the black printed lettering, and the red printed heart.

The uncertainties shown are from the Poisson counting statistics.

It is clear that for single paint layers on a plastic or other substrate, it is very useful to be able to measure the substrate independently. Since the spot size for the HD XRF measurement is small (<1 mm), removal of the surface layer in a small 2-3 mm spot can give this important information without destroying or even seriously defacing the sample. General automated FP analysis for layered samples is currently being developed and we believe measurements will be able to be quantified with uncertainty of 1–5%. Currently, quantification of layered samples by automated FP analysis is accurate to about 10–20%.

3. Mapping of Elemental Distributions with an HD XRF Analyzer

The concentration and distribution in tissue of bioessential elements such as Fe, Cu, and Zn, so-called Redox metals, have been identified as major players in cardiovascular diseases such as Friedreich’s ataxia (FRDA) and of neurological diseases including Alzheimer’s disease (AD), Parkinson’s disease (PD), multiple sclerosis (MS), Huntington’s disease (HD), aceruloplasmanemia, amyotrophic lateral sclerosis (ALS), and others. More than two dozen human nervous system disorders have been associated with oxidative tissue...
damage in which redox metals are believed to play an important role.

Although abnormal iron deposition has been associated with many neurodegenerative diseases since the association was discovered more than 50 years ago [22], its role and origin are still not well understood. A long-term objective is to correlate the location and, if possible, the oxidation state distribution of metal deposits at a subcellular level with structural abnormalities such as betaamyloid plaque (Aβ), neurofibrillary tangles, and so forth. Iron staining is widely used to determine regions of iron overload, and the distribution of nonheme iron [23, 24] and some information about the redox state of the iron can be obtained with modified staining techniques [25]. Magnetic resonance imaging (MRI) is important for study of diseases exhibiting region-specific brain-iron accumulation, and progress continues to be made in development of this technique as a diagnostic tool [26, 27]. A major benefit of nondestructive HD XRF mapping of elemental distributions is that subsequent to this measurement, staining microscopy can be carried out on the same samples to study detailed correlation of metal deposits with anatomical and pathological features.

Recently, a number of Synchrotron-based micro-X-ray fluorescence (μXRF) studies of brain sections from AD, PD, and other neurodegenerative diseases have been reported [28–33]. These studies have demonstrated the power of micro-X-ray fluorescence in such studies and have also shown that Fe, Cu, and Zn distributions are associated with β-amyloid plaque (Aβ) [18]. Unfortunately, application of the Synchrotron tool is expensive and it has limited accessibility.

There are many other instances where elemental distributions play an important role. These include measurement of lead in bone, minerals in ore and stone deposits, art history, and other forensic cases. Only two cases (metals in brain tissue and lead in bone [24]) will be shown as examples in this paper. These have been chosen in part because of the award of an NIH grant (NIH 2R44RR022001-02) to XOS for development of an instrument for these medical research applications.

A diagram of a setup for measurement of elemental distributions by HD XRF is shown in Figure 9(a). A photograph of the setup is shown in Figure 9(b). In this setup, an Oxford Mo Apogee tube was used with a power setting of 45 W. The Apogee tube has a source spot size of 90 μm. An Si(220) asymmetrical DCC was used to form a focused monochromatic Mo Kα beam. The parameters of the Si(220) DCC optic are listed in Table 10. The X-ray source was demagnified to form a 50 μm spot on the sample. The sample was mounted on a PC-controlled XYZ stage. The sample surface was parallel to the XY plane of the stage. A silicon drift detector (SDD) was used to measure the fluorescent X-rays from the sample.

A PC-based window program was used for scanning and spectrum analysis. The program can integrate the intensity under a number of selected fluorescent peaks in the XRF spectrum. The scanning was done by moving the sample in a raster pattern. The integrated intensities for selected peaks in the X-ray fluorescence spectra versus pixel location of the sample are used for analysis and creating multielement maps.

### 3.1. Scanning Measurements for Selected Samples

#### 3.1.1. Scanning of Mouse Brain Sections

Figures 10, 11, 12, 13, and 14 show the results of scanning a 100 μm thick transgenic amyloid precursor protein (APP)

### Table 7: Measured concentration of the black lettering from “I Love NY” cup.

<table>
<thead>
<tr>
<th>Element</th>
<th>Ca</th>
<th>Ti</th>
<th>V</th>
<th>Cr</th>
<th>Mn</th>
<th>Fe</th>
<th>Co</th>
<th>Zn</th>
<th>Pb</th>
</tr>
</thead>
<tbody>
<tr>
<td>Concentration (%)</td>
<td>0.64 ± 0.03</td>
<td>0.21 ± 0.04</td>
<td>0.34 ± 0.05</td>
<td>1.79 ± 0.02</td>
<td>0.58 ± 0.02</td>
<td>2.21 ± 0.03</td>
<td>3.53 ± 0.04</td>
<td>1.68 ± 0.02</td>
<td>20.5 ± 0.2</td>
</tr>
</tbody>
</table>

### Table 8: Measured concentration of the red heart from “I Love NY” cup.

<table>
<thead>
<tr>
<th>Element</th>
<th>K</th>
<th>Ca</th>
<th>Ti</th>
<th>V</th>
<th>Fe</th>
<th>Cu</th>
<th>Zn</th>
<th>Se</th>
<th>Pb</th>
</tr>
</thead>
<tbody>
<tr>
<td>Concentration (%)</td>
<td>1.98 ± 0.02</td>
<td>0.64 ± 0.03</td>
<td>0.42 ± 0.03</td>
<td>0.15 ± 0.03</td>
<td>0.07 ± 0.02</td>
<td>0.19 ± 0.03</td>
<td>0.81 ± 0.02</td>
<td>0.78 ± 0.03</td>
<td>3.69 ± 0.04</td>
</tr>
</tbody>
</table>

### Figure 8: Superposition of spectra for three features on “I Love NY” promotional cup.
Table 9: Measured concentration of the white substrate from “I Love NY” cup.

<table>
<thead>
<tr>
<th>Element</th>
<th>K</th>
<th>Ca</th>
<th>V</th>
<th>Mn</th>
<th>Fe</th>
<th>Co</th>
<th>Zn</th>
<th>Rb</th>
<th>Sr</th>
<th>Ba</th>
<th>Pb</th>
</tr>
</thead>
<tbody>
<tr>
<td>Concentration (%)</td>
<td>1.98</td>
<td>2.52</td>
<td>0.05</td>
<td>0.03</td>
<td>0.06</td>
<td>0.02</td>
<td>1.65</td>
<td>0.02</td>
<td>0.61</td>
<td>0.98</td>
<td>0.01</td>
</tr>
<tr>
<td>±</td>
<td>±0.02</td>
<td>±0.03</td>
<td>±0.03</td>
<td>±0.02</td>
<td>±0.03</td>
<td>±0.01</td>
<td>±0.02</td>
<td>±0.01</td>
<td>±0.01</td>
<td>±0.02</td>
<td>±0.01</td>
</tr>
</tbody>
</table>

Table 10: Asymmetrical Si(220) DCC optic parameters.

<table>
<thead>
<tr>
<th>Crystal</th>
<th>Focusing E</th>
<th>Source-optic dist.</th>
<th>Optic-Focus dist.</th>
<th>Flux @ 45w</th>
<th>Measured spot size</th>
</tr>
</thead>
<tbody>
<tr>
<td>Si(220)</td>
<td>17.5 keV</td>
<td>160 mm</td>
<td>80 mm</td>
<td>$1 \times 10^7$</td>
<td>50 μm</td>
</tr>
</tbody>
</table>

Figure 9: Schematic (a) and photograph (b) of a laboratory HD XRF setup for elemental mapping.

Figure 10: Raster scans for an APP mouse brain section from integration of the Compton scattering peak (a) (which shows the brain section density distribution) and the Zn distribution (b).

(sw695) mouse brain section. It should be noted that the general brain distribution scans (with all elements being measured in the same scan) were made with a beam spot of 100 μm diameter by displacing the sample from the focal spot (along the beam direction), while selected area scans were with a 50 μm spot size as listed in Table 10.

The 100 μm thick mouse brain section was mounted on a 4 μm thick Mylar film. Analysis was carried out with the same FP analysis program used for the thin air particulate samples discussed in Section 2.1. By following the DCC focusing optic with a strongly focusing polycapillary optic, it is possible to achieve a focal spot size as small as 10 μm with zooming capability to ~300 μm scans, allowing rapid general
scanning of 2 cm \( \times \) 2 cm samples (in \( \sim \) 2 hours) and ultrahigh resolution of specific areas of interest.

3.1.2. Measurements of Goat Tibia Bone Section

In collaboration with Wadsworth Laboratory (New York State Department of Health), a series of measurements were carried out on a section of the tibia of a sacrificed goat that had been fed a diet containing lead \[34\]. These measurements are summarized in order to show application of the technique for a thick solid material and to allow the results to be compared to measurements carried out by a different technique, laser ablation, inductively coupled plasma mass spectroscopy (LA-ICP-MS).

Figures 15, 16, and 17 show the results of scanning of a 5 mm thick goat bone tibia section.
Figure 13: Raster scans of the Cu peak intensity for the APP mouse brain section.

Figure 14: Quantitative scans of selected slices of Fe and Cu distributions of APP mouse brain scans.
These bone scans show a great deal of detail in the elemental distributions. They also show that it is possible to detect unexpected anomalies such as the interesting copper seam shown in Figure 15. They also show that it is possible to use the HD XRF scanning with different types of material and with thick samples. A comparison of the HD XRF scans with scans using LA-ICP-MS shown on Figure 18 gives good and even quantitative correlation. Indeed, the X-ray fluorescence results show more detail in the distributions and are more stable than the LA-ICP-MS technique. Furthermore, they are easier to do, faster, less expensive, and can be repeated, perhaps at higher resolution since they are nondestructive compared to the LA-ICP-MS method which erodes the sample.

4. HD XRF as a Platform Technology

The trend toward increasing global regulation of toxins presents an opportunity for HD XRF as a platform technology to address a number of currently important applications. HD XRF brings several advantages over previous toxin detection technologies with the combined ability to nondestructively detect very low levels, isolate small features, and give reliable results across a wide range of toxic elements as demonstrated in Sections 2 and 3. Conventional XRF analyzers and more standard analytical chemistry techniques do not possess the needed combination of reliable results and low cost per test needed in today's tightening regulatory environment. Areas that are in need of these attributes
Figure 16: X-ray fluorescence spectra from selected positions on the bone section.

Figure 17: Elemental distributions along a selected path in the goat bone section.
include consumer products, electronics, air quality monitoring, body fluids, food products, and pharmaceuticals. Many of these applications can, in principle, share a common HD XRF hardware and software platform to hasten new product introductions and lower manufacturing costs.

A prototype HD XRF analyzer has been developed. A schematic drawing of this prototype analyzer is shown in Figure 19.

### 4.1. Lead in Toys

As noted in Section 2.2.2, a topic of much current interest is the presence of lead in toys and other items to which children are exposed. Infants and young children are particularly susceptible to lead poisoning. A nurturing child absorbs up to 50% more lead. Infants and young children have the tendency towards sucking on fingers and chewing on inedible products. Lead damages the central nervous system, causing delayed mental and physical development, attention, and learning deficiency. Any unnecessary exposure of children to lead should be avoided. The large number of toy recalls in the past two years and growing concern over continued existence of contaminated toys in use and in the distribution channel emphasize the need for a sensitive, quantitative, and efficient method for control of toxins in consumer products. The inefficiency and expense of current, largely chemical techniques available to measure contamination at the desired levels and with the necessary precision and accuracy have led to development of an easy-to-use HD XRF instrument for screening and quantitative evaluation of toys, jewelry, and other consumer products. Figure 20 shows photographs of such an analyzer currently under evaluation.

It is important to be able to measure small features as well as thin layers on toys. Examples of toys showing that lead is present in small features are shown in Figure 21. It is clear that the concern for lead in children’s goods will soon extend to other toxic elements and to other consumer goods. The broad applicability of HD XRF for accurate and sensitive measurements of more than two dozen elements in virtually all materials and matrices make it a natural and powerful platform for such measurements.

### 4.2. Toxins in Electronic Materials

#### RoHS

Electronics manufacturing has also attracted significant regulatory control. RoHS (2002/96/EG) and WEEE (2002/95/EG) regulations have created the need to inspect electronics for global markets. This application is very attractive to HD XRF since the small spot capabilities for analysis of circuit board components of the type shown on Figure 22 offer a big advantage over handheld XRF and significant cost and time savings over bench top XRF and chemical digestion methods. The actual HD XRF instrument may be a stand-alone manually operated system.
similar to the HD XRF analyzer shown in Figure 20, or a programmable automated system integrated with other inspection technologies within a factory.

5. Conclusions

Selected examples show the usefulness of HD XRF in a wide range of applications in science, medicine, and industry. By judicious choice of the source, optics, and detector type, and configuration, it is possible to reach previously unattained levels of sensitivity (down to a few ppb), elemental specificity, and spatial definition in compact, low-power, reliable, rugged, and nondestructive analyzers for clinical-, field-, online-, and laboratory-based applications.

Acknowledgments

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References


